

## MICROCIRCUIT DATA SHEET

Original Creation Date: 08/03/95 Last Update Date: 06/17/98

Last Major Revision Date: 05/27/98

### HIGH SPEED OPERATIONAL AMPLIFIER

### General Description

MNLM6164-X REV 2A1

The LM6164 high-speed amplifier exhibits an excellent speed-power product in delivering 300 V/uS and 175 MHz GBW (stable down to gains as low as +5) with only 5 mA of supply current. Further, power savings and application convenience are possible by taking advantage of the wide dynamic range in operating supply voltage which extends all the way down to +5V.

This amplifier is built with National's VIP[TM] (Vertically Integrated PNP) process which provides fast PNP transistors that are true complements to the already fast NPN devices. This advanced junction-isolated process delivers high speed performance without the need for complex and expensive dielectric isolation.

### Industry Part Number

NS Part Numbers

LM6164

Prime Die

LM6164B

LM6164J-QMLV\* LM6164J/883\*\* LM6164W/883 \*\*\* LM6164WG-QMLV\*\*\*\* LM6164WG/883\*\*\*\*

### Controlling Document

See Features Page

### Processing

MIL-STD-883, Method 5004

### Quality Conformance Inspection

MIL-STD-883, Method 5005

Subgrp	Description	Temp	( °C)
1 2	Static tests at Static tests at	+25 +125	
3	Static tests at	-55	
4 5	Dynamic tests at Dynamic tests at	+25 +125	
6	Dynamic tests at	-55	
7	Functional tests at	+25	
8A 8B	Functional tests at	+125 -55	
9	Switching tests at	+25	
10	Switching tests at		
11	Switching tests at	-55	

### **Features**

- High slew rate 300 V/uS - High GBW product 175MHz - Low supply current 5mA - Fast settling 100nS to 0.1% - Low differential gain <0.1% - Low differential phase <0.1 degrees - Wide supply range 4.75V to 32V - Stable with unlimited capacitive load - SMD : 5962-8962401VPA\*, PA\*\*, HA\*\*\*, VXA\*\*\*\*, XA\*\*\*\*\*

# Applications

- Video amplifier
- Wide-bandwidth signal conditioning
- Radar
- Sonar

## (Absolute Maximum Ratings)

(Note 1)

```
Supply Voltage
   (V+ - V-)
                                                           36V
Differential Input Voltage Range
(Note 4)
                                                           <u>+</u>8V
Common-Mode Input Voltage Range
 (Note 6)
                                                           (V+ - 0.7V) to (V- - 7V)
Output Short Circuit to Gnd
(Note 3)
                                                           Continuous
Power Dissipation
(Note 2)
                                                           400mW
Soldering Information
    (Soldering, 10 seconds)
                                                           260 C
Storage Temperature Range
                                                           -65 C to +150 C
Maximum Junction Temperature
                                                           150 C
Thermal Resistance
    ThetaJA
      CERDIP
                     (Still Air)
                                                           113 C/W
                     (500LF/Min Air flow)
                                                            51 C/W
      CERPAK
                     (Still Air)
                                                           228 C/W
                     (500LF/Min Air flow)
                                                           140 C/W
      CERAMIC SOIC
                     (Still Air)
                                                           228 C/W
                     (500LF/Min Air flow)
                                                           140 C/W
    ThetaJC
      CERDIP
                                                            21 C/W
      CERPAK
                                                            21 C/W
      CERAMIC SOIC
                                                            21 C/W
Package Weight
    (Typical)
    CERDIP
                                                           TBD
    CERPAK
                                                           TBD
    CERAMIC SOIC
                                                           220mg
ESD Tolerance
(Note 4, 5)
                                                           ±500V
```

- Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

  The maximum power dissipation must be derated at elevated temperatures and is
- Note 2: dictated by Tjmax (maximum junction temperature), ThetaJA (package junction to ambient thermal resistance), and TA (ambient temperature). The maximum allowable power dissipation at any temperature is Pdmax = (Tjmax - TA)/ThetaJA or the number given in the Absolute Maximum Ratings, whichever is lower.
- Note 3:
- Continuous short-circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150 C.

  In order to achieve optimum AC performance, the input stage was designed without protective clamps. Exceeding the maximum differential input voltage results in Note 4: reverse breakdown of the base-emitter junction of one of the input transistors and probable degradation of the input parameters (especially Vio, Ios, and Noise).
- Note 5: The average voltage that the weakest pin combinations (those involving Pin 2 or Pin 3) can withstand and still conform to the datasheet limits. The test circuit used consists of the human body model of 100pF in series with 1500 Ohms.
- Note 6: The voltage between V+ and either input pin must not exceed 36V.

# Recommended Operating Conditions

(Note 1)

Temperature Range

-55 C  $\leq$  TA  $\leq$  +125 C

Supply Voltage Range

4.75V to 32V

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

# Electrical Characteristics

### DC PARAMETERS

(The following conditions apply to all the following parameters, unless otherwise specified.) DC: Vcc =  $\pm 15$ V, Vcm = 0V, Rl  $\geq$  100K Ohms, Rs = 10K Ohms.

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN- NAME	MIN	MAX	UNIT	SUB- GROUPS
Vio	Input Offset Voltage				-4	4	mV	1
	Voicage				-6	6	mV	2, 3
Iib	Input Bias Current				-3	3	uA	1
	Current				-6	6	uA	2, 3
Iio	Input Offset Current				-350	350	nA	1
	Current				-800	800	nA	2, 3
+Vcmr	Positive Common-Mode	Vcc = <u>+</u> 15V			13.9		V	1
	Voltage Range	Vcc = <u>+</u> 15V			13.8		V	2, 3
		Vcc = +5V	2		3.9		V	1
			2		3.8		V	2, 3
-Vcmr	Negative Common-Mode	Vcc = <u>+</u> 15V				-13.3	V	1
	Voltage Range	Vcc = <u>+</u> 15V				-13.1	V	2, 3
		Vcc = +5V	2			1.7	V	1
			2			1.9	V	2, 3
CMRR	Common-Mode Rejection Ratio	-12.9V ≤ Vcm ≤ 13.9V			86		dB	1
	Rejection Ratio	-12.7V ≤ Vcm ≤ 13.8V			80		dB	2, 3
PSRR	Power Supply Rejection Ratio	$\pm 10V \leq Vcc \leq \pm 16V$			86		dB	1
	Rejection Ratio	±10V ≤ Vcc ≤ ±16V			80		dВ	2, 3
Ios	Output Short Circuit Current	Source				-30	mA	1
	Circuit Current					-20	mA	2, 3
		Sink			30		mA	1
					20		mA	2, 3
Icc	Supply Current					6.5	mA	1
						6.8	mA	2, 3
Avs	Large Signal Voltage Gain	Vout = $\pm 10V$ , Rl = 2K Ohms	1		1.8		V/mV	1
	Voicage Gain	Vout = $\pm 10$ V, Rl = 2K Ohms	1		0.9		V/mV	2, 3
+Vop	Positive Voltage Swing	$Vcc = \pm 15V$ , $Rl = 2K$ Ohms			13.5		V	1
	SWIIIA	$Vcc = \pm 15V$ , $Rl = 2K$ Ohms			13.3		V	2, 3
		Vcc = +5V, Rl = 2K Ohms			3.5		V	1
					3.3		V	2, 3

### Electrical Characteristics

### DC PARAMETERS (Continued)

(The following conditions apply to all the following parameters, unless otherwise specified.) DC: Vcc =  $\pm 15$ V, Vcm = 0V, Rl  $\geq$  100K Ohms, Rs = 10K Ohms.

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN- NAME	MIN	MAX	UNIT	SUB- GROUPS
-Vop	Negative Voltage Swing	$Vcc = \pm 15V$ , $Rl = 2K$ Ohms				-13.0	V	1
	Swiing	$Vcc = \pm 15V$ , $Rl = 2K$ Ohms				-12.7	V	2, 3
		Vcc = +5V, Rl = 2K Ohms				1.7	V	1
						2.0	V	2, 3

### AC PARAMETERS

(The following conditions apply to all the following parameters, unless otherwise specified.) AC:  $Vcc = \pm 15V$ , Vcm = 0V,  $Rl = \ge 100K$  Ohms, Rs = 10K Ohms.

Gbw	Gain Bandwidth Product	f = 20Mhz		140		MHz 4	4
				80		MHz	5, 6
+Sr	Slew Rate	Output step = -10V to +10V, Av = +5, Vin = 4V step		200		V/uS	4
		VIII IV BOOF		180		V/uS	5, 6
-Sr	Slew Rate	Output step = +10V to -10V, Av = +5, Vin = 4V step		200		V/uS	4
		VIII - IV BEED		180		V/uS	5, 6
ts	Setting Time	10V step to 0.1% , Av = -4, R1 = 2K Ohms			275	V/uS ·	9
		KI - Zit Olimb			300	nS	10, 11

### DC PARAMETERS: DRIFT VALUES

(The following conditions apply to all the following parameters, unless otherwise specified.) DC:  $Vcc = \pm 15V$ , Vcm = 0V,  $Rl = \ge 100K$  Ohms, Rs = 10K Ohms. "Delta calculations performed on QMLV devices at Group B, Subgroup 5 ONLY"

Vio	Input Offset Voltage		-0.6	+0.6	mV	1
Iib	Input Bias Current		-0.5	+0.5	uA	1
Iio	Input Offset Current		-35	+35	nA	1
CMRR	Common-Mode Rejection Ratio	-12.9V ≤ Vcm ≤ 13.9V	-5	+5	dВ	1

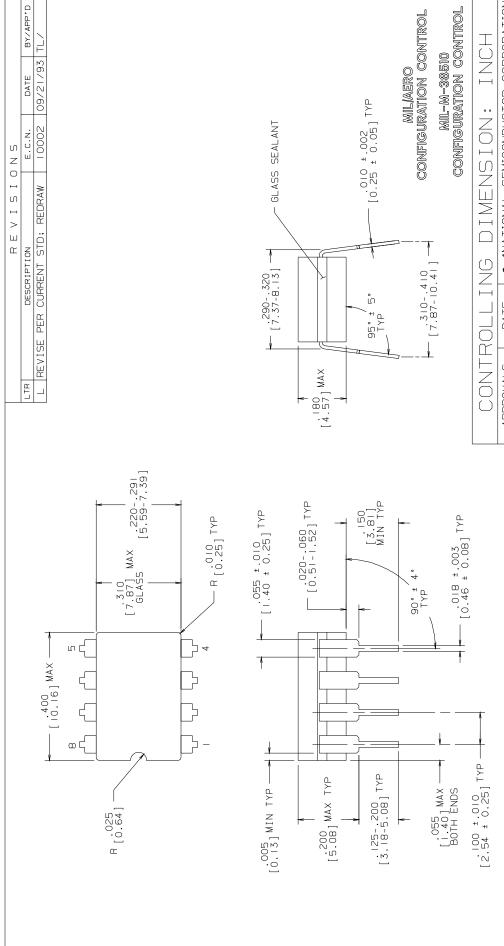
Note 1: Voltage gain is the total output swing (20V) divided by the signal required to produce that swing.

Note 2: For single supply operation, the following conditions apply: V+ = 5V, V- = 0V, Vcm = 2.5V, Vout = 2.5V. Vio adjust pins are each connected to V- to realize maximum output swing. This connection will degrade Vio.

# Graphics and Diagrams

GRAPHICS#	DESCRIPTION
05885HRA4	CERDIP (J), 8 LEAD (B/I CKT)
06190HRA3	CERPACK (W, WG), 10LD (B/I CKT)
J08ARL	CERDIP (J), 8 LEAD (P/P DWG)
P000246A	CERDIP (J), 8 LEAD (PINOUT)
P000247A	CERPACK (W), 10 LEAD (PINOUT)
P000362A	CERAMIC SOIC (WG), 10 LEAD (PINOUT)
W10ARG	CERPACK (W), 10 LEAD (P/P DWG)
WG10ARC	CERAMIC SOIC (WG), 10 LEAD (P/P DWG)

See attached graphics following this page.



NATIONAL SEMICONDUCTOR CORPORATION 2900 Semiconductor Drive, Santa Clara, CA 95052-8090 MKT-J08A CERDIP (, 8 LEAD  $\forall$ | DRAWN\_T. LEQUANG | 09/21/93 DATE PROJECTION APPROVALS DFTG. CHK. ENGR. CHK. APPROVAL

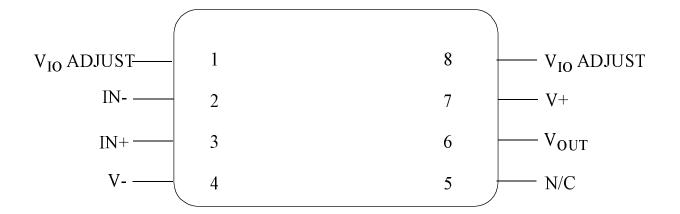
> 1. LEAD FINISH TO BE 200 MICROINCHES / 5.08 MICROMETERS MINIMUM SOLDER MEASURED AT THE CREST OF THE MAJOR FLATS. 2. JEDEC REGISTRATION MO-036, VARIATION AA, DATED 04/1981.

NOTES: UNLESS OTHERWISE SPECIFIED

R V

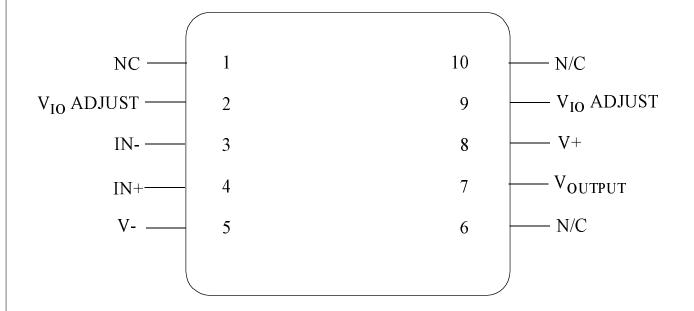
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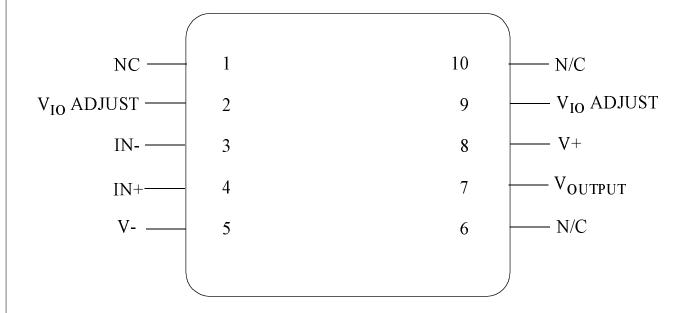
# LM6164J 8 - LEAD DIP CONNECTION DIAGRAM TOP VIEW P000246A





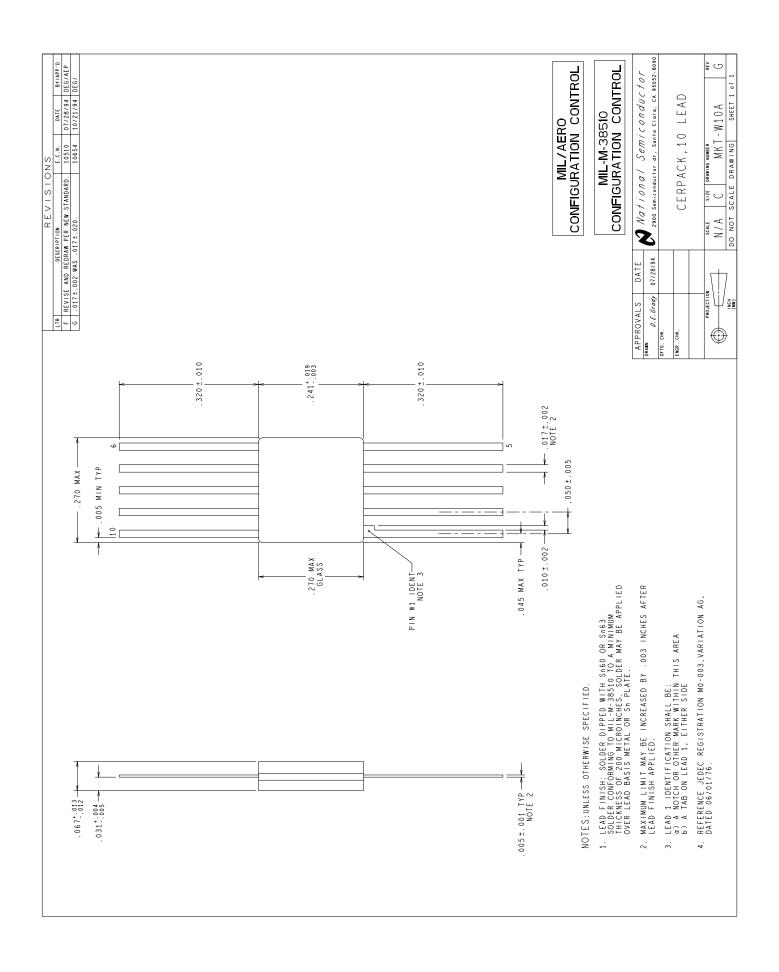
# LM6164W 10 - LEAD CERPACK CONNECTION DIAGRAM TOP VIEW P000247A

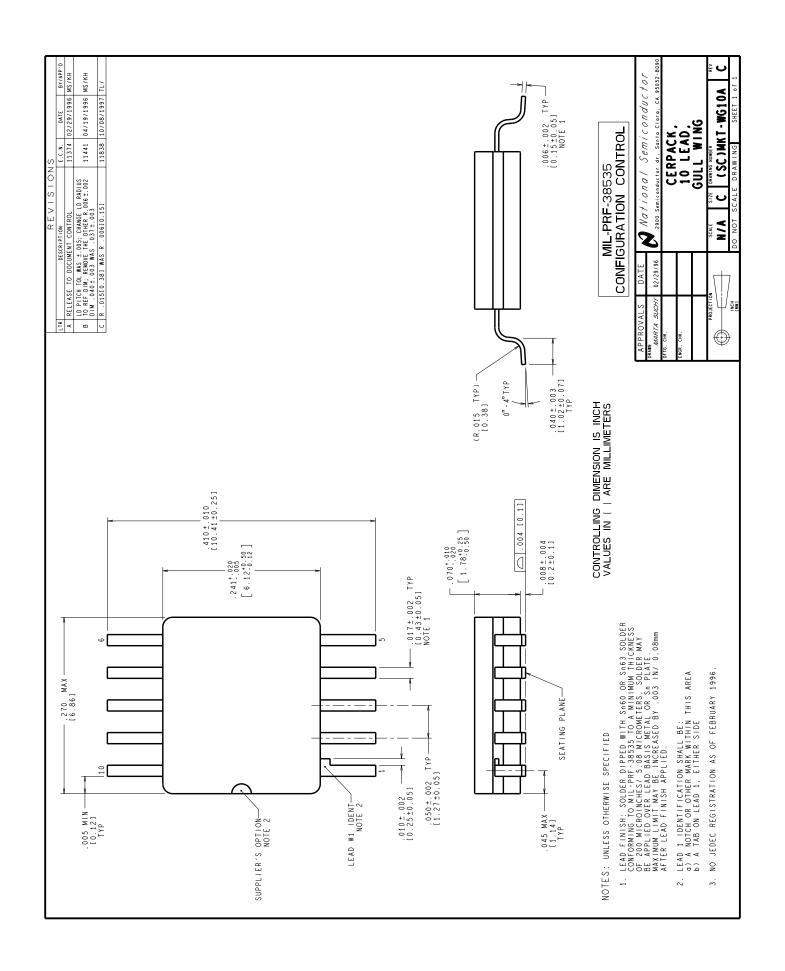




# LM6164WG 10 - LEAD CERAMIC SOIC CONNECTION DIAGRAM TOP VIEW P000362A







# Revision History

Rev	ECN #	Rel Date	Originator	Changes
1A1	M0002856	06/17/98	Barbara Lopez	Update MDS: MNLM6164-X Rev. 0A0 to MNLM6164-X Rev. 1A1. Deleted E and W-SMD ID. Added WG ID. Added SMD number for WG package. Added package weight. Added WG package to thermal resistance, updated note 6, deleted note 7, added power dissipation limit to Absolute section. Updated subgroups to match SMD, added note 2 in Electrical section. Added MKT, Burn-In CKT and Pinout for all packages.
2A1	M0002906	06/17/98	Rose Malone	Updated MDS: MNLM6164-X, Rev. 1A1 to MNLM6164-X, Rev. 2A1. Package Weight for Ceramic SOIC, Drift Section and QMLV reference. Arranged the SMD references in the Features section to match Main Table.